

# N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}$ (m $\Omega$ )(Typ.)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
30	1.5 at V <sub>GS</sub> = 10 V	119	39 nC			
30	2.4 at V <sub>GS</sub> = 4.5 V	119				

#### **FEATURES**

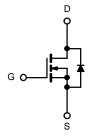
- DT-SGT Power MOSFET
- 100 % Rg and UIS tested
- Excellent FoM (Figure of Merit)

#### **APPLICATIONS**

- Motor Drive
- · Li- Battery Protection
- Power Managment for High Performance Application

### PDFN3.3X3.3-8L Pin Configuration

**Top View** 7 D S [ 2 S [ 3 6 ] D G [ 4 5 ] D



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	V <sub>DS</sub>	30	V			
Gate-Source Voltage	V <sub>GS</sub>	± 20	V			
Operation of Paris Comment (T., 450,00).	T <sub>C</sub> = 25 °C	,	119	А		
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>C</sub> = 100 °C	I <sub>D</sub>	75			
Pulsed Drain Current <sup>b</sup>	I <sub>DM</sub>	475				
Single Avalanche Energy	E <sub>AS</sub>	270	mJ			
Maximum Dawar Dissination (	T <sub>C</sub> = 25 °C	В	38	W		
Maximum Power Dissipation <sup>c</sup>	T <sub>C</sub> = 100 °C	P <sub>D</sub>	15	VV		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C			

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	LIMIT	UNIT		
Junction-to-Ambient (PCB Mount) <sup>d</sup>	$R_{thJA}$	60	°C/W		
Junction-to-Case (Drain)	$R_{thJC}$	3.3	C/VV		

- a. Calculated continuous current based on maximum allowablejunction temperature.
- b. Repetitive rating; pulse width limited by max. junction temperature.
- c. Pd is based on max. junction temperature, using junction-case thermal resistance.
- d. The value of Reja is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with Ta=25 °C.



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$ $V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		30	-	-	V	
Gate Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		-	2.5		
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	μA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 30  V,  V_{GS} = 0  V$	-	-	1	μΑ	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	100		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le 5 \text{ V}, V_{GS} = 10 \text{ V}$	119	-	-	Α	
Drain-Source On-State Resistance <sup>a</sup>	D	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	1.5	1.8	m0	
Dialit-Source Oit-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 20 A	-	2.4	3.0	mΩ	
Forward Transconductancea	9 <sub>fs</sub>	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 20 A	-	33	-	S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>		-	2517	-	pF	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 15 \text{ V}, f = 1 \text{ MHz}$	-	1731	-		
Reverse Transfer Capacitance	C <sub>rss</sub>		-	142	-		
Total Gate Charge <sup>c</sup>	$Q_g$		-	39	-	nC	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	7.2	-		
Gate-Drain Charge <sup>c</sup>	$Q_{gd}$		-	7.4	-		
Gate Resistance	$R_g$			1.3	-	Ω	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>		-	5.4	-		
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, I_{D} = 20 \text{ A}, R_{GEN} = 3 \Omega$	-	11	-		
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	V <sub>GS</sub> = 10 V	-	29	-	ns	
Fall Time <sup>c</sup>	t <sub>f</sub>		-	12	-		
Drain-Source Body Diode Ratings and	Characterist	ics <sup>b</sup> (T <sub>J</sub> = 25 °C)					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	106	Α	
Pulsed Current	I <sub>SM</sub>		-	-	475	Α	
Forward Voltage <sup>a</sup>	$V_{SD}$	I <sub>F</sub> = 2 A, V <sub>GS</sub> = 0 V	-	0.7	1.2	V	
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 20 A, di/dt = 100 A/μs	-	46	-	ns	
Reverse Recovery Charge	Q <sub>rr</sub>	i <sub>F</sub> = 20 A, αί/αι = 100 A/μS	-	37	-	nC	

#### **Notes**

- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those in dicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended pe riods may affect device reliability.



#### TYPICAL CHARAC TERISTICS (25 °C, unless otherwise noted)

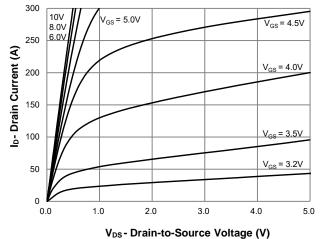


Figure 1: Output Characteristics



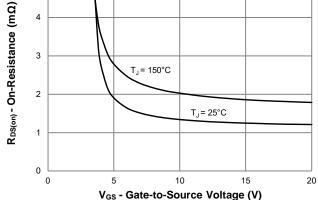


Figure 3: On-Resistance vs. Gate-Source Voltage

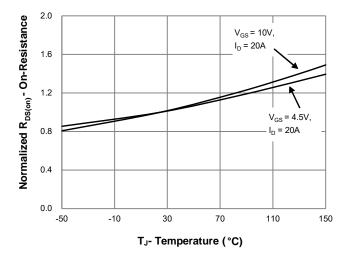
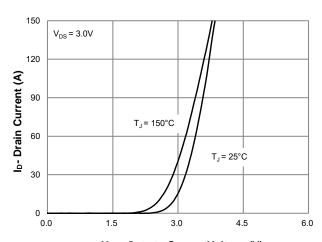


Figure 5: On-Resistance vs. Junction Temperature



V<sub>GS</sub>- Gate-to-Source Voltage (V)

Figure 2: Transfer Characteristics

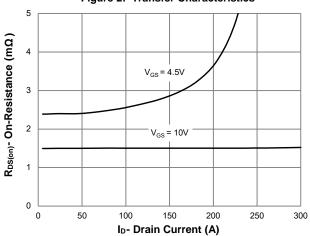
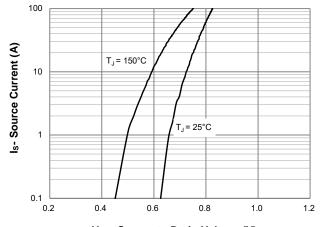


Figure 4: On-Resistance vs. Gate-Source Voltage



V<sub>SD</sub> - Source-to-Drain Voltage (V)

Figure 6: Source-Drain Diode Forward Voltage



#### TYPICAL CHARAC TERISTICS (25 °C, unless otherwise noted)

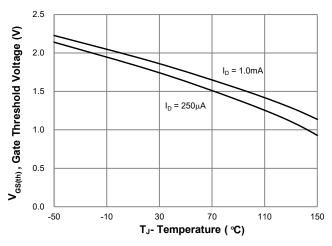


Figure 7: Gate Threshold Variation vs. Junction Temperature

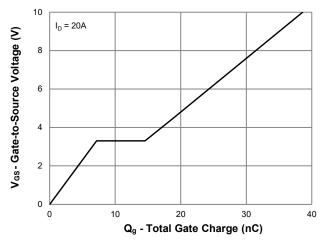


Figure 8: Gate Charge Characteristics

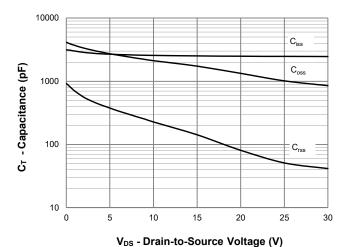


Figure 9: Capacitance Characteristics

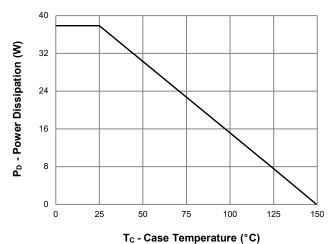


Figure 10: Power Derating

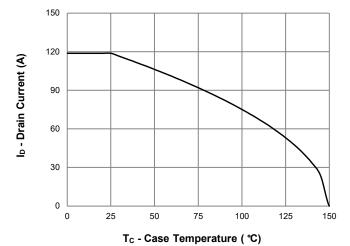
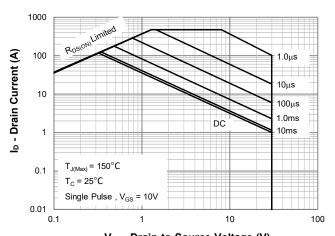


Figure 11: Current Derating



V<sub>DS</sub> - Drain-to-Source Voltage (V)

Figure 12: Safe Operating Area



TYPICAL CHARAC TERISTICS (25 °C, unless otherwise noted)

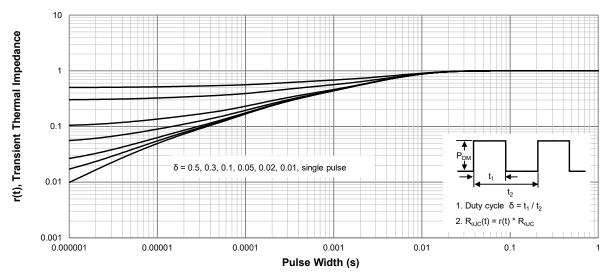
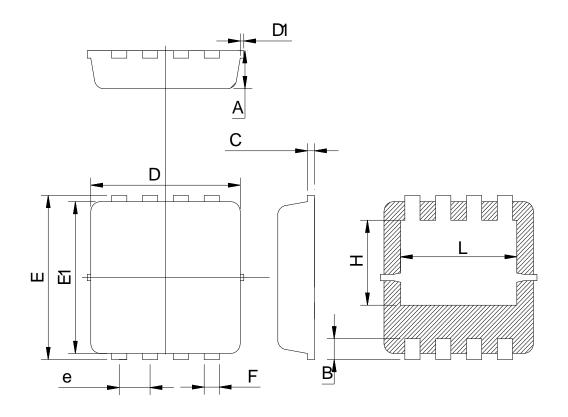


Figure 13: Normalized Maximum Transient Thermal Impedance



# **PDFN 3.3X3.3 PACKAGE OUTLINE**



## **COMMON DIMENSIONS** (UNITS OFMEASURE=MILLIMETER)

Symbol	Min	Тур	Max
А	0.600	0.775	1.000
В	0.20	0.38	0.55
С	0.05	0.15	0.40
D	3.10	3.25	3.50
D1	-	-	0.15
Е	3.15	3.35	3.50
E1	2.60	3.10	3.45
е	0.50	0.65	0.80
F	0.15	0.32	0.45
Н	1.25	1.73	2.10
L	2.20	2.45	2.85





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